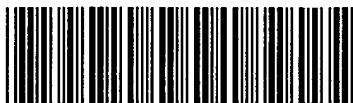


Search Notes

Application/Control No.

10/500,674

Examiner

Noah Kamen

Applicant(s)/Patent under
Reexamination

BEIL ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	41E	6/20/2006	NK
	406.58		
	617		
73	116		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (including PLUS results)	6/20/2006	NK